



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Shunpei Yamazaki, et al. Art Unit: 2811
Serial No.: 10/727,651 Examiner: Unknown

Filed: December 5, 2003

Title : THIN FILM TRANSISTORS AND SEMICONDUCTOR DEVICE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT AND SUBMISSION OF CORRECTED FORM PTO-1449

Supplemental to an information disclosure statement filed with the application on December 5, 2003, Applicants submit the attached corrected Form PTO-1449. All of the documents listed on the form PTO-1449 were cited in information disclosure statement filed with the application. The corrected Form PTO-1449 is being submitted to correct typographical errors in the description of three references identified as Desig. ID "AD," "BF" and "BN." Please note that the Patentee in Desig. ID "AD" has been changed from "Change, et al." to "Chang, et al." and the Publication Date in Desig ID as been changed from "04/1991" to "10/28/1992." In addition, the translation identification for TW310478 (Desig. ID "BF") has been changed from "Full" to "Abstract."

This statement is being filed before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 29, 2004

John F. Hayden Reg. No. 37,640

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Substitute Form PTO-1449 (Modified)

(37 CFR §1.98(b))

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 12732-051002

Application No.
New Application

**Information Disclosure Statement by Applicant** (Use several sheets if necessary)

Filing Date
December 5, 2003

Applicant Shunpei Yamazaki, et al.

Group Art Unit Unknown

| U.S. Patent Documents |              |                    |                     |                   |       |          |                            |
|-----------------------|--------------|--------------------|---------------------|-------------------|-------|----------|----------------------------|
| Examiner<br>Initial   | Desig.<br>ID | Document<br>Number | Publication<br>Date | Patentee          | Class | Subclass | Filing Date If Appropriate |
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| Examiner Signature   | Date Considered  |
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| EXAMINER: Initials citation considered. Draw line through citation if no | t in conformance and not considered. Include conv. of this form with |

next communication to applicant.

| Substitute Form PTO-1449 (Modified)                 |                                  | artment of Commerce<br>and Trademark Office |                                       |                           |  |  |
|---|----------------------------------|---|---------------------------------------|---------------------------|--|--|
|   | n Disclosure Sta<br>by Applicant | tement                                      | Applicant<br>Shunpei Yamazaki, et al. |                           |  |  |
| (Use several sheets if necessary) (37 CFR §1.98(b)) |                                  |   | Filing Date December 5, 2003          | Group Art Unit<br>Unknown |  |  |
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|---------------------|------------------|--------------|-------------|-----------------------------|----------|------------|-------------|------------|
| Examiner<br>Initial | Desig.           | Document     | Publication | Country or<br>Patent Office | Class    | 0          | Translation |            |
| muai                | <del> - '-</del> | Number       | Date        | Patent Office               | Class    | Subclass   | Yes         | No         |
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|                     | ВО               |              |             |                             |          |            |             |            |

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|   | BR     |   |  |  |  |

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| Examiner Signature   | Date Considered   |
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